

Absolute Maximum Ratings @ 25°C

Parameter	Ratings	Units
Blocking Voltage	400	V _P
Reverse Input Voltage	5	V
Input Control Current	100	mA
Peak (10ms)	1	Α
Input Power Dissipation ¹	150	mW
P _{MAX} , Total Package Dissipation ²	1600	mW
Isolation Voltage, Input to Output	3750	V _{rms}
Operational Temperature	-40 to +85	°C
Storage Temperature	-40 to +125	°C

Absolute Maximum Ratings are stress ratings. Stresses in excess of these ratings can cause permanent damage to the device. Functional operation of the device at conditions beyond those indicated in the operational sections of this data sheet is not implied.

Typical values are characteristic of the device at +25°C, and are the result of engineering evaluations. They are provided for information purposes only, and are not part of the manufacturing testing requirements.

¹ Derate linearly 1.33 mW / °C ² Derate linearly 16.6 mW / °C

Electrical Characteristics @ 25°C

Conditions	Symbol	Min	Тур	Max	Units
		I		I	<u>, 1</u>
V	-	20	-	120	V _{rms}
V _L =120V _{rms}	I _L	0.005	-	1	A _{rms}
-	I _{TSM}	-	-	10	A
V _L =400V _P	ILEAK	-	-	1	mA
I _L =1A _{rms}		-	-	1.6	V _{rms}
-	dV/dt	1000	-	-	V/µs
L_E mA	t _{on}	-	-	0.5	avalaa
I _F =D IIIA		-	-	0.5	cycles
1st half-cycle	-	-	2	10	V
Subsequent half-cycle	-	-	1	-	V
-	-	20	-	400	Hz
-	PF	0.25	-	-	-
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-	I _F	-	0.8	5	mA
I _F =5mA	V _F	0.9	1.2	1.5	V
-	-	0.8	-	-	V
V _R =5V	I _B	-	-	10	μΑ
					<u>.</u>
V _{IO} =0V, f=1MHz	CIO	-	3	-	pF
	VL VL=120Vrms - VL=400VP IL=1Arms - Ist half-cycle Subsequent half-cycle - - - - 0 -	$\begin{tabular}{ c c c c } \hline V_L & - & & & & & & & & & & & & & & & & & $	$\begin{array}{c c c c c c c c c c c c c c c c c c c $	$\begin{array}{c c c c c c c c c c c c c c c c c c c $	$\begin{array}{c c c c c c c c c c c c c c c c c c c $

¹ Zero Cross 1st half-cycle @ <100Hz ² Snubber circuits may be required at low power factors.

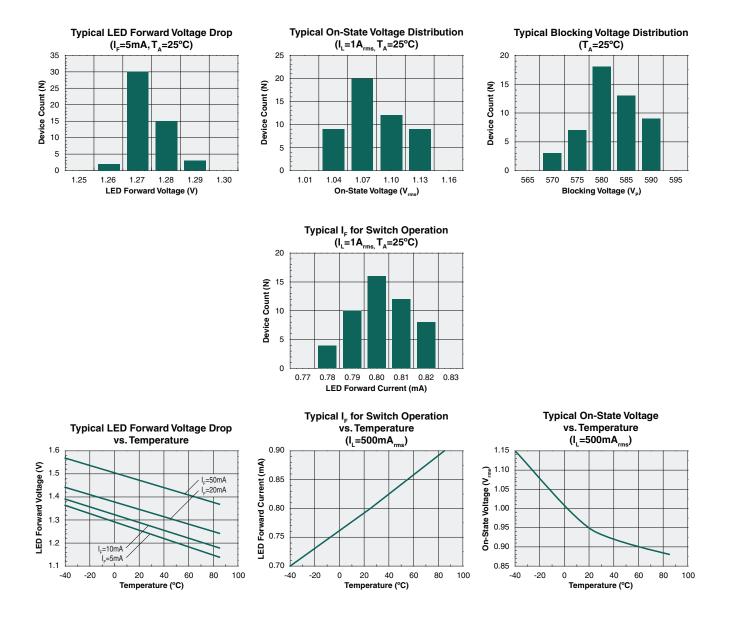
³ Tested in accordance with EIA/NARM standard RS-443.

 $^{\rm 4}$ For high noise environments, use I $_{\rm F}{=}10{\rm mA}.$



CPC1945G

PERFORMANCE DATA*

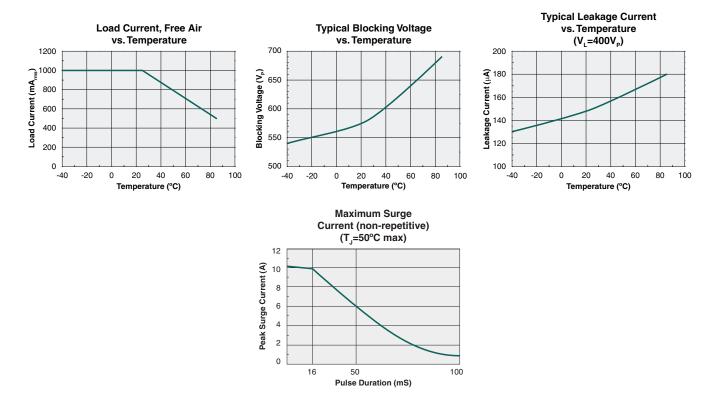


*Unless otherwise noted, data presented in these graphs is typical of device operation at 25°C. For guaranteed parameters not indicated in the written specifications, please contact our application department.

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PERFORMANCE DATA*



*Unless otherwise noted, data presented in these graphs is typical of device operation at 25°C. For guaranteed parameters not indicated in the written specifications, please contact our application department.



Manufacturing Information

Moisture Sensitivity

All plastic encapsulated semiconductor packages are susceptible to moisture ingression. IXYS Integrated Circuits classifies its plastic encapsulated devices for moisture sensitivity according to the latest version of the joint industry standard, **IPC/JEDEC J-STD-020**, in force at the time of product evaluation. We test all of our products to the maximum conditions set forth in the standard, and guarantee proper operation of our devices when handled according to the limitations and information in that standard as well as to any limitations set forth in the information or standards referenced below.

Failure to adhere to the warnings or limitations as established by the listed specifications could result in reduced product performance, reduction of operable life, and/or reduction of overall reliability.

This product carries a Moisture Sensitivity Level (MSL) classification as shown below, and should be handled according to the requirements of the latest version of the joint industry standard **IPC/JEDEC J-STD-033**.

Device	Moisture Sensitivity Level (MSL) Classification
CPC1945G	MSL 1

ESD Sensitivity



This product is **ESD Sensitive**, and should be handled according to the industry standard **JESD-625**.

Soldering Profile

Provided in the table below is the Classification Temperature (T_c) of this product and the maximum dwell time the body temperature of this device may be $(T_c - 5)^\circ$ C or greater. The classification temperature sets the Maximum Body Temperature allowed for this device during lead-free reflow processes. For through-hole devices, and any other processes, the guidelines of **J-STD-020** must be observed.

Device	Classification Temperature (T _c)	Dwell Time (t _p)	Max Reflow Cycles
CPC1945G	245°C	30 seconds	1

Board Wash

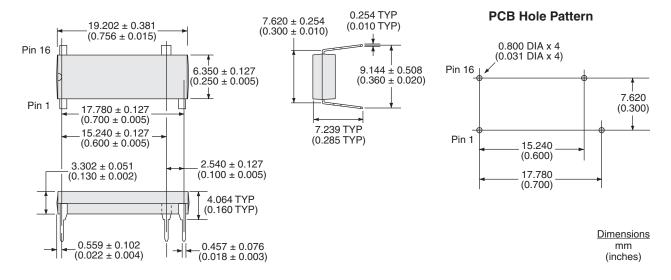
IXYS Integrated Circuits recommends the use of no-clean flux formulations. Board washing to reduce or remove flux residue following the solder reflow process is acceptable provided proper precautions are taken to prevent damage to the device. These precautions include, but are not limited to: using a low pressure wash and providing a follow up bake cycle sufficient to remove any moisture trapped within the device due to the washing process. Due to the variability of the wash parameters used to clean the board, determination of the bake temperature and duration necessary to remove the moisture trapped within the package is the responsibility of the user (assembler). Cleaning or drying methods that employ ultrasonic energy may damage the device and should not be used. Additionally, the device must not be exposed to flux or solvents that are Chlorine- or Fluorine-based.





MECHANICAL DIMENSIONS

CPC1945G



For additional information please visit our website at: www.ixysic.com

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